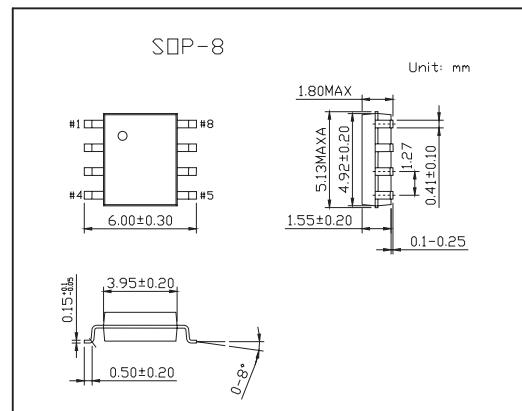
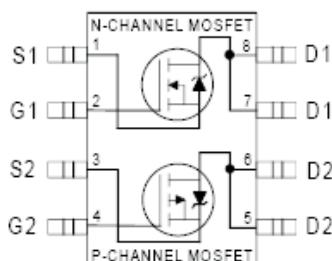


HEXFET® Power MOSFET

KRF7317

■ Features

- Generation V Technology
- Ultra Low On-Resistance
- Dual N and P Channel MOSFET
- Surface Mount
- Fully Avalanche Rated



■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	N-Channel	P-Channel	Unit	
Drain-Source Voltage	V _{DS}	20	-20	V	
Continuous Drain Current Ta = 25°C	I _D	6.6	-5.3	A	
Continuous Drain Current Ta = 70°C	I _D	5.3	-4.3		
Pulsed Drain Current	I _{DM}	26	-21		
Continuous Source Current (Diode Conduction)	I _S	2.5	-2.5	W	
Power Dissipation @Ta= 25°C *2	P _D	2.0			
Power Dissipation @Ta= 70°C *2		1.3			
Single Pulse Avalanche Energy	E _{AS}	100	150	mJ	
Avalanche Current	I _{AR}	4.1	-2.9	A	
Repetitive Avalanche Energy	E _{AR}	0.20		mJ	
Peak Diode Recovery dv/dt *1	dv/dt	5.0	-5	V/ ns	
Gate-to-Source Voltage	V _{GS}	±12		V	
Junction and Storage Temperature Range	T _J , T _{STG}	-55 to + 150		°C	
Maximum Junction-to-Ambient *2	R _{θ JA}	62.5		°C/W	

*1 N-Channel I_{SD} ≤ 4.1A, di/dt ≤ 92A/μ s, V_{DD} ≤ V_{(BR)DSS}, T_J ≤ 150°C

P-Channel I_{SD} ≤ -2.9A, di/dt ≤ -77A/μ s, V_{DD} ≤ V_{(BR)DSS}, T_J ≤ 150°C

*2 Surface mounted on FR-4 board, t ≤ 10sec.

KRF7317■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250 \mu A$	N-Ch	20		V
		$V_{GS} = 0V, I_D = -250 \mu A$	P-Ch	-20		
Breakdown Voltage Temp. Coefficient	$\Delta V_{(BR)DSS}/\Delta T_J$	$I_D = 1\text{mA}, \text{Reference to } 25^\circ\text{C}$	N-Ch	0.027		$\text{V}/^\circ\text{C}$
		$I_D = -1\text{mA}, \text{Reference to } 25^\circ\text{C}$	P-Ch	0.031		
Static Drain-to-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 6.0A^*$	N-Ch	0.023	0.029	Ω
		$V_{GS} = 2.7V, I_D = 5.2A^*$		0.030	0.046	
		$V_{GS} = -4.5V, I_D = -2.9A^*$	P-Ch	0.049	0.058	
		$V_{GS} = -2.7V, I_D = -1.5A^*$		0.082	0.098	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$	N-Ch	0.7		V
		$V_{DS} = V_{GS}, I_D = -250 \mu A$	P-Ch	-0.7		
Forward Transconductance	g_{fs}	$V_{DS} = 10V, I_D = 6.0A^*$	N-Ch	20		S
		$V_{DS} = -10V, I_D = -1.5A^*$	P-Ch	5.9		
Drain-to-Source Leakage Current	I_{DSS}	$V_{DS} = 16V, V_{GS} = 0V$	N-Ch		1.0	μA
		$V_{DS} = -16V, V_{GS} = 0V$	P-Ch		-1.0	
		$V_{DS} = 16V, V_{GS} = 0V, T_J = 55^\circ\text{C}$	N-Ch		5.0	
		$V_{DS} = -16V, V_{GS} = 0V, T_J = 55^\circ\text{C}$	P-Ch		-25	
Gate-to-Source Forward Leakage	I_{GSS}	$V_{GS} = \pm 12V$	N-Ch		± 100	nA
			P-Ch		± 100	
Total Gate Charge	Q_g	N-Channel $I_D = 6.0A, V_{DS} = 10V, V_{GS} = 4.5V$	N-Ch	18	27	nC
Gate-to-Source Charge	Q_{gs}		P-Ch	19	29	
Gate-to-Drain ("Miller") Charge	Q_{gd}	P-Channel $I_D = -2.9A, V_{DS} = -16V, V_{GS} = -4.5V$	N-Ch	2.2	3.3	
			P-Ch	4.0	6.1	
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 10V, I_D = 1.0A, R_G = 6.0 \Omega$ P-Channel $R_D = 10 \Omega$ $V_{DD} = -10V, I_D = -2.9A, R_G = 6.0 \Omega$ $R_D = 3.4 \Omega$	N-Ch	6.2	9.3	ns
Rise Time	t_r		P-Ch	7.7	12	
Turn-Off Delay Time	$t_{d(off)}$		N-Ch	8.1	12	
Fall Time	t_f		P-Ch	15	22	
Input Capacitance	C_{iss}		N-Ch	17	25	
Output Capacitance	C_{oss}		P-Ch	40	60	
Reverse Transfer Capacitance	C_{rss}	N-Channel $V_{GS} = 0V, V_{DS} = 15V, f = 1.0\text{MHz}$ P-Channel $V_{GS} = 0V, V_{DS} = -15V, f = 1.0\text{MHz}$	N-Ch	38	57	pF
			P-Ch	42	63	
			N-Ch	31	47	
			P-Ch	49	73	

KRF7317■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit		
Continuous Source Current (Body Diode)	I_S		N-Ch		2.5	A		
Pulsed Source Current (Body Diode) *2			P-Ch		-2.5			
Diode Forward Voltage	V_{SD}	$T_J = 25^\circ\text{C}, I_S = 1.7\text{A}, V_{GS} = 0\text{V}^*3$	N-Ch		26	V		
		$T_J = 25^\circ\text{C}, I_S = -2.9\text{A}, V_{GS} = 0\text{V}^*3$	P-Ch		-21			
Reverse Recovery Time	t_{rr}	N-Channel $T_J = 25^\circ\text{C}, I_F = 1.7\text{A}, di/dt = 100\text{A}/\mu\text{s}^*1$	N-Ch	0.72	1.0	ns		
Reverse Recovery Charge			P-Ch	-0.78	-1.0			
	Q_{rr}	P-Channel $T_J = 25^\circ\text{C}, I_F = -2.9\text{A}, di/dt = -100\text{A}/\mu\text{s}^*1$	N-Ch	52	77			
			P-Ch	47	71			
			N-Ch	58	86	nC		
			P-Ch	49	73			

*1 Pulse width $\leq 300 \mu\text{s}$; duty cycle $\leq 2\%$.

*2 Repetitive rating; pulse width limited by max. junction temperature.

*3 N-Channel Starting $T_J = 25^\circ\text{C}$, $L = 12\text{mH}$ $R_G = 25\Omega$, $I_{AS} = 4.1\text{A}$.P-Channel Starting $T_J = 25^\circ\text{C}$, $L = 35\text{mH}$ $R_G = 25\Omega$, $I_{AS} = -2.9\text{A}$.